

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/060,163 | Applicant(s)/Patent Under Reexamination KASAHARA ET AL. | |
| | Examiner Christina Ildebrando | Art Unit 1725 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| | A | US-6,047,544 | 04-2000 | Yamamoto et al. | 60/285 |
| | B | US-5,837,642 | 11-1998 | Tanaka et al. | 502/304 |
| | C | US-5,057,483 | 10-1991 | Wan, Chung-Zong | 502/304 |
| | D | US-2003/0153453 | 08-2003 | Kasahara et al. | 502/64 |
| | E | US-2003/0108465 | 06-2003 | Voss et al. | 423/213.2 |
| | F | US-6,413,898 | 07-2002 | Faber et al. | 502/64 |
| | G | US-6,261,989 | 07-2001 | Tanaka et al. | 502/217 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.